THE UNITED STATES PATENT AND TRADEMARK

TC 2800 MAIL ROOM C. MCKINNY

In re application of:

Allan Rosencwaig et al.

Application No.: 09/629,407

Filed: August 1, 2000

For: MEASUREMENT OF THIN FILMS

> AND BARRIER LAYERS ON PATTERNED WAFERS X-RAY

REFLECTOMETRY

Examiner:

Group No.: 2876

SUBMISSION OF POWER OF ATTORNEY AND CHANGE OF ATTORNEY OR

AGENT'S ADDRESS IN APPLICATION

Commissioner for Patents Washington, DC 20231

Sir:

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Enclosed for filing please find a duly executed Power of Attorney by Assignee for the above-identified application which specifies an Assignment recordal date of October 3, 2000, at Reel 11157, Frame 913, and shows Assignee's entire right, title and interest to establish ownership.

Also enclosed for filing is a Change of Attorney or Agent's Address in Application (37 CFR 1.8(a)).

Respectfully submitted,

STALLMAN & POLLOCK LLP

April 7

Michael A. Stallman (Reg. No. 29,444)

Attorneys for Applicant(s)

121 Spear Street, Suite 290 San Francisco, CA 94105

Tel.: (415) 512-1312 Fax: (415) 512-1362

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In re Patent Application of

Group Art: 2876 HAY -2 2001

876 TC 2800 MAIL ROOM

Allan Rosencwaig et al.

Examiner:

Appln. No.: 09/629,407

Applii. No.: 09/029,407

Filed: August 1, 2000

For: MEASUREMENT OF THIN FILMS AND BARRIER LAYERS ON PATTERNED WAFERS WITH X-RAY

REFLECTOMETRY

POWER OF ATTORNEY BY ASSIGNEE

Commissioner for Patents Washington, D.C. 20231

Sir:

THERMA-WAVE, INC., assignee of the entire right title and interest in the above-identified application by assignment dated August 15, 2000, which assignment was recorded in the Patent and Trademark Office on October 3, 2000, at Reel 11157, frame 913, hereby appoints the members of the firm of STALLMAN & POLLOCK LLP, a firm composed of:

Michael A. Stallman 29,444 Michael J. Pollock 29,098 Kathleen A. Frost 37,326

as its attorneys with full power of substitution to prosecute this application and to transact all business in the Patent and Trademark Office in connection therewith.

Please direct all correspondence regarding this application to the following:

STALLMAN & POLLOCK LLP Attn: Michael A. Stallman 2001 Ferry Building San Francisco, CA 94111

Telephone: (415) 433-4150 Facsimile: (415-433-8716

Dated: 3-5-00

THERMA-WAVE, INC.

Name: Martin Schwartz

Title: Chief Executive Officer

## nange Of Attorney Or Agent's Address In Application (37 CFR 1.8(a))

Docket No.

Sp 2876

TWI-10820

pplication Of: Allan Rosencwaig et al.

HAY -2 2001

RECEIVED

Serial No. 09/629,407

Filing Date August 1, 2000 Exantifie 2800 MAIL ROOM Group Art Unit Unknown

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Invention: MEASUREMENT OF THIN FILMS AND BARRIER LAYERS ON PATTERNED WAFERS WITH X-RAY RÉFLECTOMETRY

## TO THE ASSISTANT COMMISSIONER FOR PATENTS

Please send all correspondence for this application to:

STALLMAN & POLLOCK LLP Attn: Michael A. Stallman 121 Spear Street, Suite 290 San Francisco, CA 94105

Please direct all telephone calls to:

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Signature of Attorney or Agent of Record

Michael A. Stallman (Reg. No. 29,444)

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Telephone: (415) 512-1312

Registration Number & Address of Attorney or Agent of Record

Dated: April 27, 2001

certify that this document is being deposited on April 27, 2001 with the U.S. Postal Service as first class mail under 37 C.F.R. 1.8 and is addressed to the Assistant Commissioner for Patents, Washington, D.C. 20231.

Signature of Person Mailing Correspondence

Georgia K. Stith

Typed or Printed Name of Person Mailing Correspondence